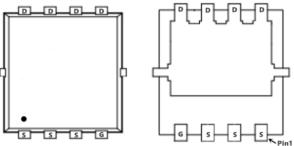
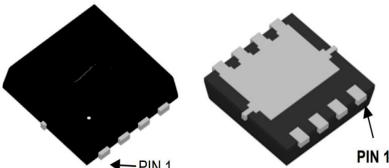
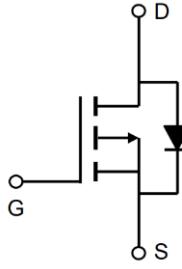


**TM35P03DF**
**P -Channel Enhancement Mosfet**

<b>General Description</b>		<b>General Features</b>	
<ul style="list-style-type: none"> <li>• Low R<sub>DS(ON)</sub></li> <li>• RoHS and Halogen-Free Compliant</li> </ul>		V <sub>DS</sub> = -30V I <sub>D</sub> = -35A R <sub>DS(ON)</sub> = 16mΩ(typ.) @ V <sub>GS</sub> = -10V 100% UIS Tested 100% R <sub>g</sub> Tested	
<b>Applications</b>			
<ul style="list-style-type: none"> <li>• Load switch</li> <li>• PWM</li> </ul>			
 Marking:35P03		DF:DFN3.3x3.3-8L  	
<b>Absolute Maximum Ratings</b> (T <sub>A</sub> = 25°C unless otherwise noted)			
Symbol	Parameter	Rating	Unit
<b>Common Ratings</b>			
V <sub>DSS</sub>	Drain-Source Voltage	-30	V
V <sub>GSS</sub>	Gate-Source Voltage	±20	
I <sub>D</sub>	Continuous Drain Current	T <sub>c</sub> =25°C T <sub>c</sub> =100°C	-35 -21
I <sub>DM</sub>	Pulsed Drain Current *	T <sub>c</sub> =25°C	-105
I <sub>S</sub>	Diode Continuous Forward Current	T <sub>c</sub> =25°C	-16
P <sub>D</sub>	Power Dissipation	T <sub>c</sub> =25°C T <sub>c</sub> =100°C	28.9 11.9
I <sub>AS</sub> <sup>a</sup>	Single pulsed avalanche current	L=0.5mH	14
E <sub>AS</sub> <sup>a</sup>	Single pulsed avalanche energy	L=0.5mH	49
R <sub>θJC</sub>	Thermal Resistance-Junction to Case <sup>b</sup>	Steady State	4.2 °C/W
R <sub>θJA</sub>	Thermal Resistance-Junction to Ambient	t≤10S Steady State	40 °C/W 75
T <sub>STG</sub> , T <sub>j</sub>	Storage Temperature Range	-55 to 150	°C

Note \* : Current limited by bond wire.

Note a : UIS tested and pulse width are limited by maximum junction temperature 150°C (initial temperature T<sub>J</sub> = 25°C).  
Note b : t<10s.

## Electrical Characteristics (T<sub>A</sub> = 25°C unless otherwise noted)

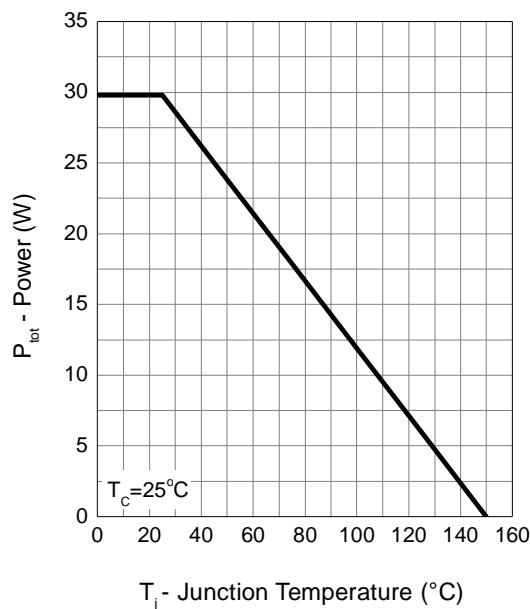
Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
<b>Static Characteristics</b>						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V, I <sub>DS</sub> =-250μA	-30	-	-	V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =-24V, V <sub>GS</sub> =0V	-	-	-1	μA
		T <sub>J</sub> =85°C	-	-	-30	
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>DS</sub> =-250μA	-1.0	-1.5	-2.0	V
I <sub>GSS</sub>	Gate Leakage Current	V <sub>GS</sub> =±25V, V <sub>DS</sub> =0V	-	-	±100	nA
R <sub>DS(ON)</sub> <sup>c</sup>	Drain-Source On-state Resistance	V <sub>GS</sub> =-10V, I <sub>DS</sub> =-16A	-	16	21	mΩ
		V <sub>GS</sub> =-4.5V, I <sub>DS</sub> =-8A	-	22	32	
<b>Body Diode Characteristics</b>						
V <sub>SD</sub> <sup>c</sup>	Diode Forward Voltage	I <sub>SD</sub> =-1A, V <sub>GS</sub> =0V	-	-0.7	-1.0	V
t <sub>rr</sub> <sup>d</sup>	Reverse Recovery Time	I <sub>DS</sub> =-16A, dI <sub>SD</sub> /dt=100A/μs	-	18	-	ns
Qrr <sup>d</sup>	Reverse Recovery Charge		-	9	-	nC
<b>Dynamic Characteristics</b>						
R <sub>G</sub>	Gate Resistance	F=1MHz, V <sub>GS</sub> =0V	-	4	-	Ω
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> =0V, V <sub>DS</sub> =-15V, Frequency=1.0MHz	-	1080	-	pF
C <sub>oss</sub>	Output Capacitance		-	220	-	
C <sub>rss</sub>	Reverse transfer capacitance		-	170	-	
t <sub>d(ON)</sub>	Turn-on delay Time	V <sub>GS</sub> =-10V ,V <sub>DS</sub> =-15V RG=6Ω, ID=-1A,R <sub>L</sub> =15Ω	-	11.2	-	nS
t <sub>r</sub>	Turn-on rise Time		-	10.6	-	
t <sub>d(OFF)</sub>	Turn-off delay Time		-	37	-	
t <sub>f</sub>	Turn-off rise Time		-	50	-	
<b>Gate Charge Characteristics</b>						
Q <sub>g</sub>	Total Gate Charge	V <sub>DS</sub> =-15V, V <sub>GS</sub> =-10V, I <sub>DS</sub> =-16A	-	20	-	nC
Q <sub>gs</sub>	Gate-Source Charge		-	1.1	-	
Q <sub>gd</sub>	Gate-Drain Charge		-	7.7	-	

Note c : Pulse test ; pulse width≤300μs, duty cycle≤2%.

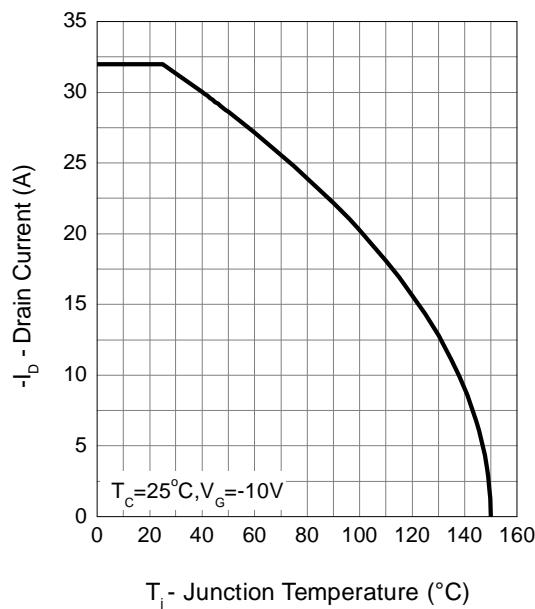
Note d : Guaranteed by design, not subject to production testing.

## Typical Characteristics

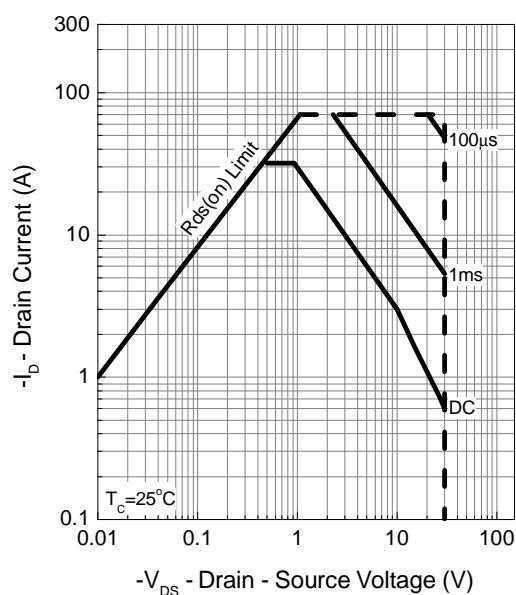
**Power Dissipation**



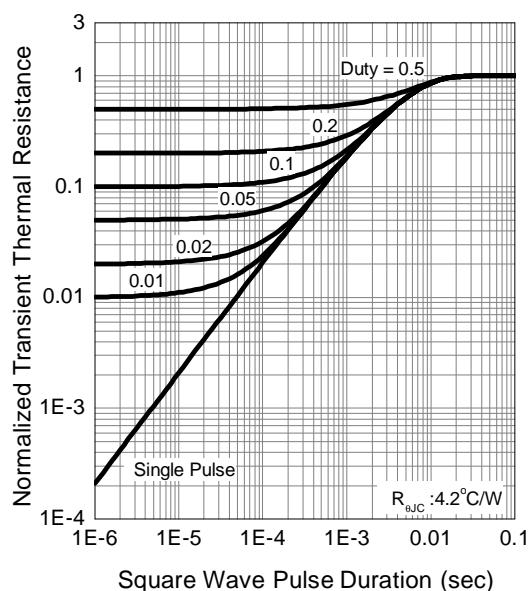
**Drain Current**



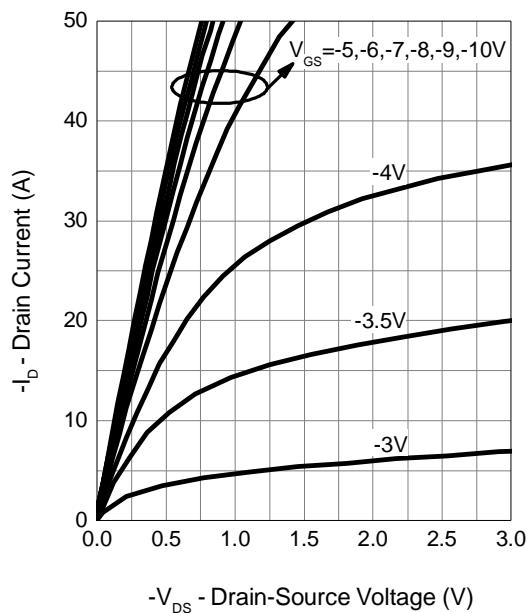
**Safe Operation Area**



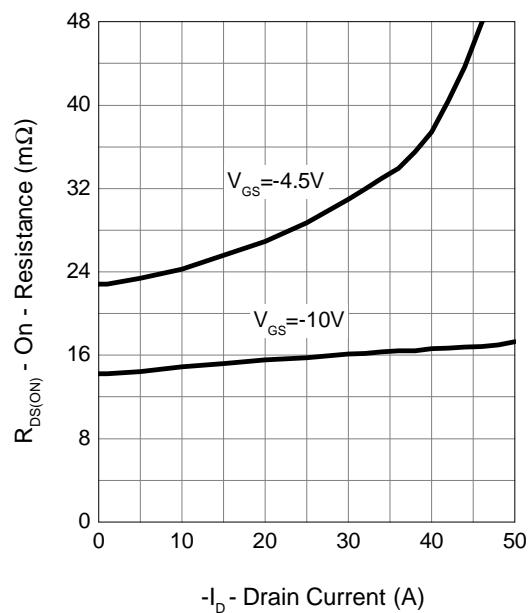
**Thermal Transient Impedance**



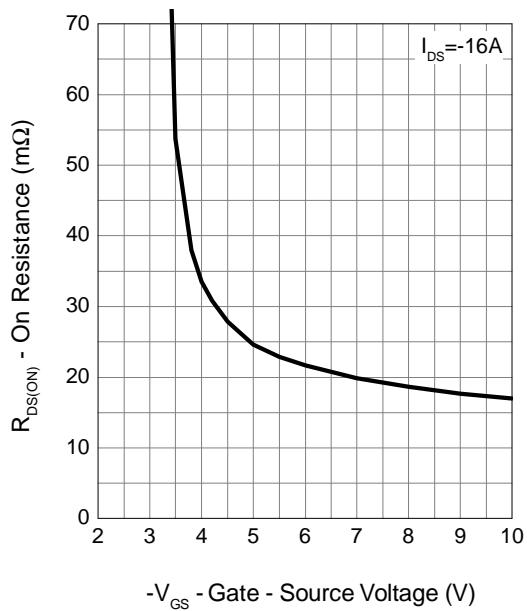
**Output Characteristics**



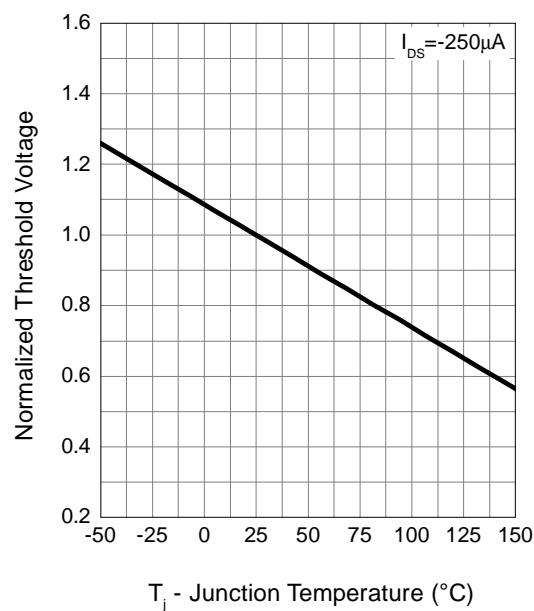
**Drain-Source On Resistance**



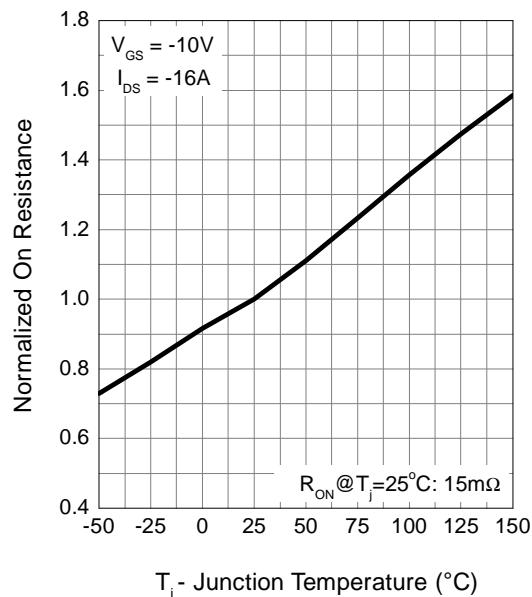
**Gate-Source On Resistance**



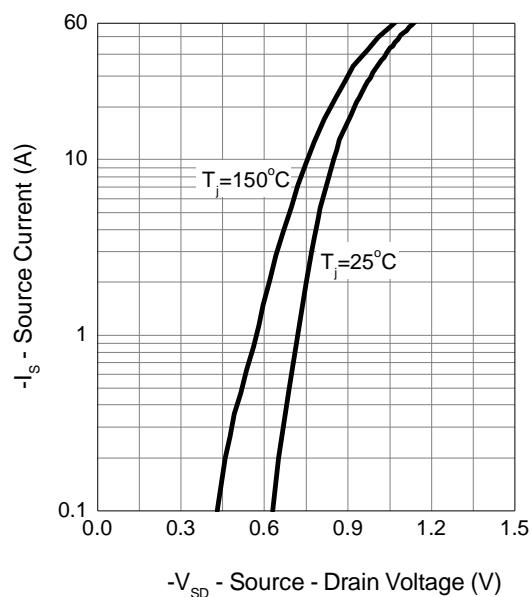
**Gate Threshold Voltage**



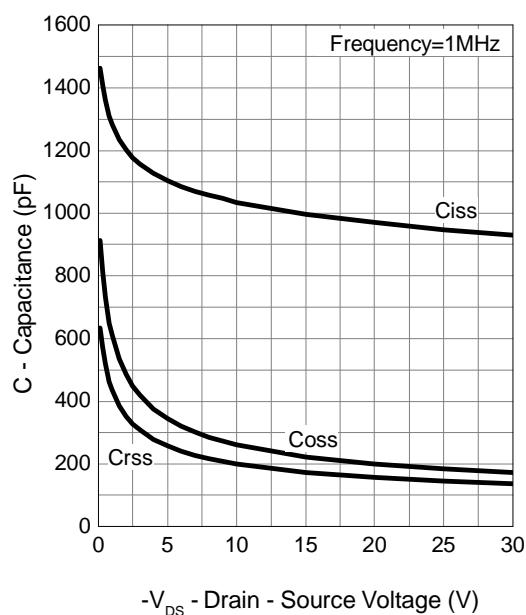
**Drain-Source On Resistance**



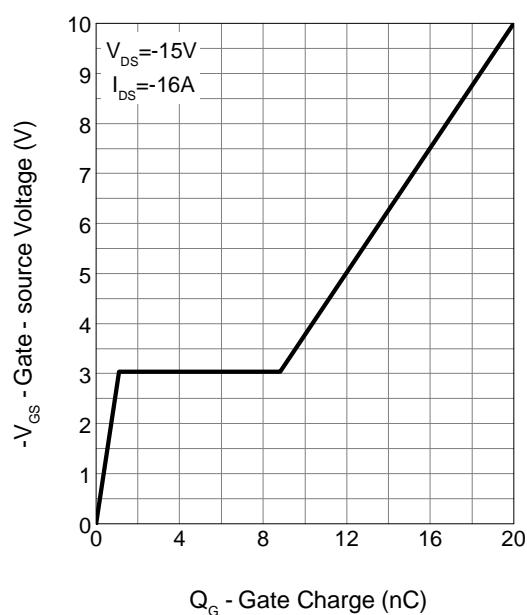
**Source-Drain Diode Forward**



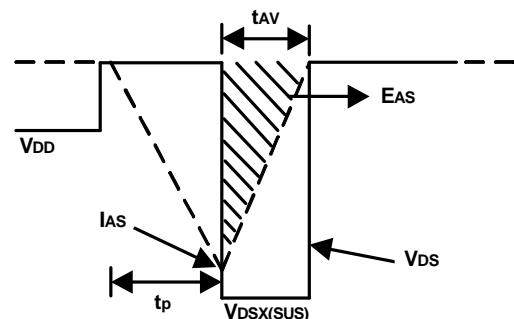
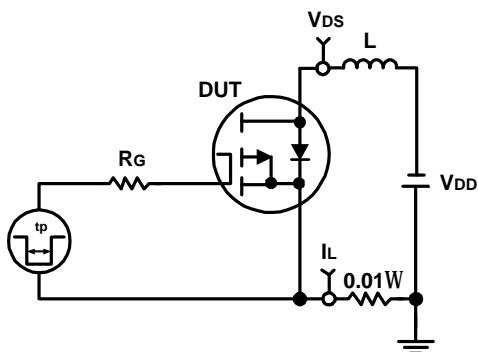
**Capacitance**



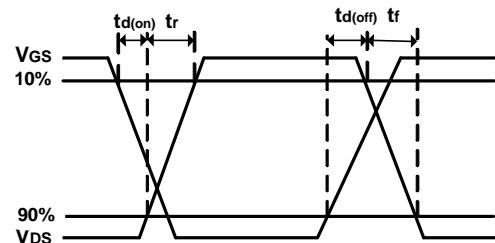
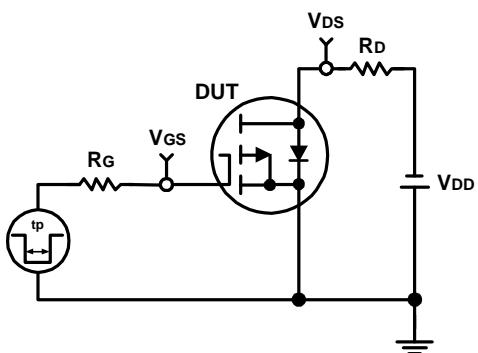
**Gate Charge**



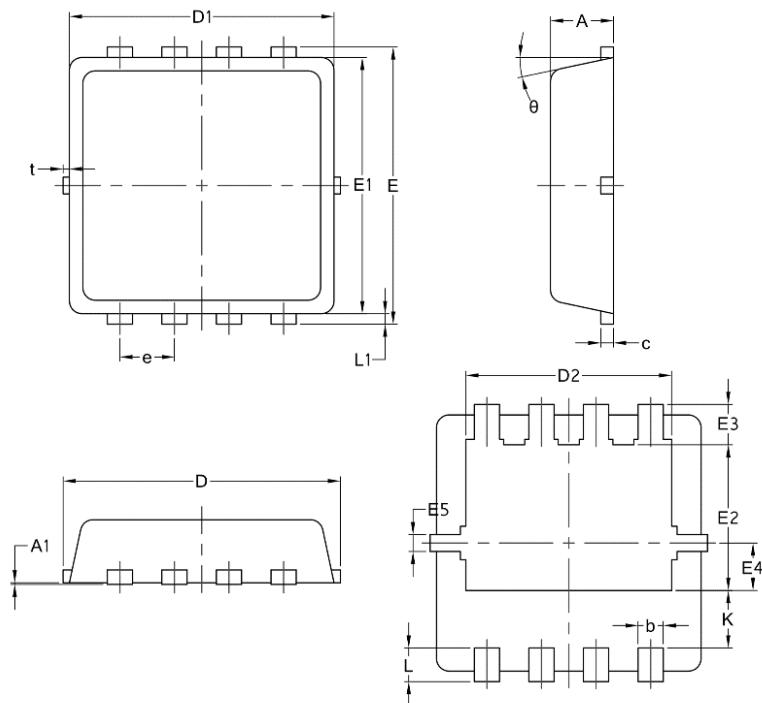
## Avalanche Test Circuit and Waveforms



## Switching Time Test Circuit and Waveforms



## Package Mechanical Data:DFN3x3-8L



Symbol	Common		
	mm		
	Mim	Nom	Max
A	0.70	0.75	0.85
A1	/	/	0.05
b	0.20	0.30	0.40
c	0.10	0.152	0.25
D	3.15	3.30	3.45
D1	3.00	3.15	3.25
D2	2.29	2.45	2.65
E	3.15	3.30	3.45
E1	2.90	3.05	3.20
E2	1.54	1.74	1.94
E3	0.28	0.48	0.65
E4	0.37	0.57	0.77
E5	0.10	0.20	0.30
e	0.60	0.65	0.70
K	0.59	0.69	0.89
L	0.30	0.40	0.50
L1	0.06	0.125	0.20
t	0	0.075	0.13
$\Phi$	10	12	14